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Details

Product Status	Active
Core Processor	STM8
Core Size	8-Bit
Speed	16MHz
Connectivity	I ² C, IrDA, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, DMA, IR, LCD, POR, PWM, WDT
Number of I/O	68
Program Memory Size	64KB (64K x 8)
Program Memory Type	FLASH
EEPROM Size	2K x 8
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 3.6V
Data Converters	A/D 28x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	80-LQFP
Supplier Device Package	80-LQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/stm8l152m8t3

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3.3.3 Voltage regulator

The high-density and medium+ density STM8L15xx6/8 devices embed an internal voltage regulator for generating the 1.8 V power supply for the core and peripherals.

This regulator has two different modes:

- **Main voltage regulator mode (MVR)** for Run, Wait for interrupt (WFI) and Wait for event (WFE) modes.
- **Low-power voltage regulator mode (LPVR)** for Halt, Active-halt, Low-power run and Low-power wait modes.

When entering Halt or Active-halt modes, the system automatically switches from the MVR to the LPVR in order to reduce current consumption.

3.4 Clock management

The clock controller distributes the system clock (SYSCLK) coming from different oscillators to the core and the peripherals. It also manages clock gating for low-power modes and ensures clock robustness.

Features

- **Clock prescaler:** to get the best compromise between speed and current consumption the clock frequency to the CPU and peripherals can be adjusted by a programmable prescaler
- **Safe clock switching:** Clock sources can be changed safely on the fly in run mode through a configuration register.
- **Clock management:** To reduce power consumption, the clock controller can stop the clock to the core, individual peripherals or memory.
- **System clock sources:** 4 different clock sources can be used to drive the system clock:
 - 1-16 MHz High speed external crystal (HSE)
 - 16 MHz High speed internal RC oscillator (HSI)
 - 32.768 Low speed external crystal (LSE) available on STM8L151xx and STM8L152xx devices
 - 38 kHz Low speed internal RC (LSI)
- **RTC and LCD clock sources:** the above four sources can be chosen to clock the RTC and the LCD, whatever the system clock.
- **Startup clock:** After reset, the microcontroller restarts by default with an internal 2 MHz clock (HSI/8). The prescaler ratio and clock source can be changed by the application program as soon as the code execution starts.
- **Clock security system (CSS):** This feature can be enabled by software. If a HSE clock failure occurs, the system clock is automatically switched to HSI.
- **Configurable main clock output (CCO):** This outputs an external clock for use by the application.

3.9 Analog-to-digital converter

- 12-bit analog-to-digital converter (ADC1) with 28 channels (including 4 fast channel), temperature sensor and internal reference voltage
- Conversion time down to 1 μ s with $f_{\text{SYSCLK}} = 16$ MHz
- Programmable resolution
- Programmable sampling time
- Single and continuous mode of conversion
- Scan capability: automatic conversion performed on a selected group of analog inputs
- Analog watchdog: interrupt generation when the converted voltage is outside the programmed threshold
- Triggered by timer

Note: ADC1 can be served by DMA1.

3.10 Digital-to-analog converter

- 12-bit DAC with 2 buffered outputs (two digital signals can be converted into two analog voltage signal outputs)
- Synchronized update capability using timers
- DMA capability for each channel
- External triggers for conversion
- Noise-wave generation
- Triangular-wave generation
- Dual DAC channels with independent or simultaneous conversions
- Input reference voltage $V_{\text{REF+}}$ for better resolution

Note: DAC can be served by DMA1.

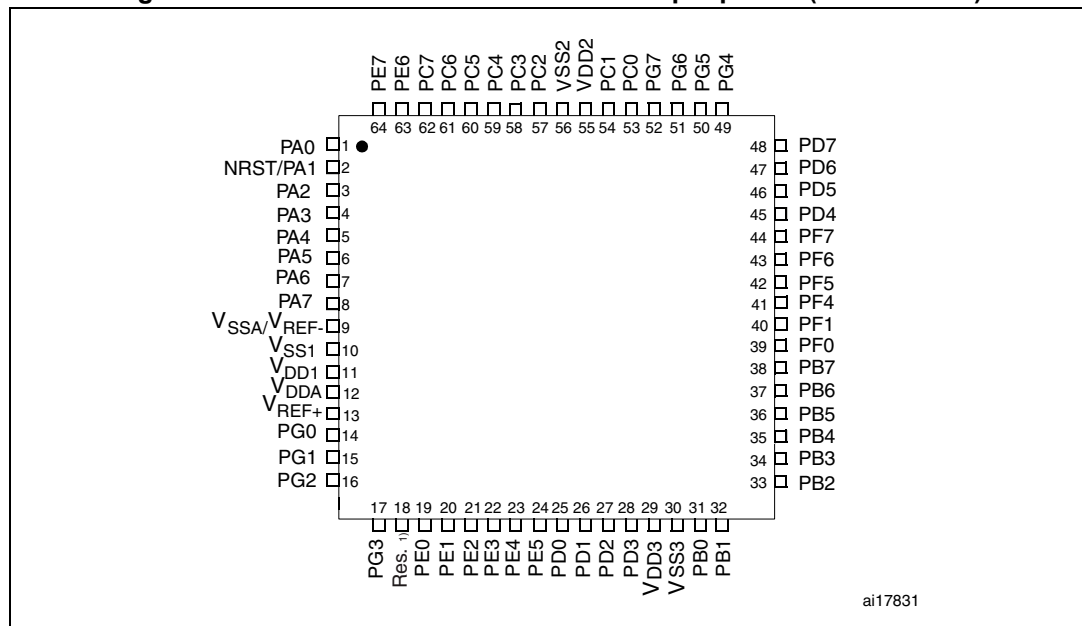
3.11 Ultra-low-power comparators

The high-density and medium+ density STM8L15xx6/8 devices embed two comparators (COMP1 and COMP2) sharing the same current bias and voltage reference. The voltage reference can be internal or external (coming from an I/O).

- One comparator with fixed threshold (COMP1).
- One comparator rail to rail with fast or slow mode (COMP2). The threshold can be one of the following:
 - DAC output
 - External I/O
 - Internal reference voltage or internal reference voltage submultiple (1/4, 1/2, 3/4)

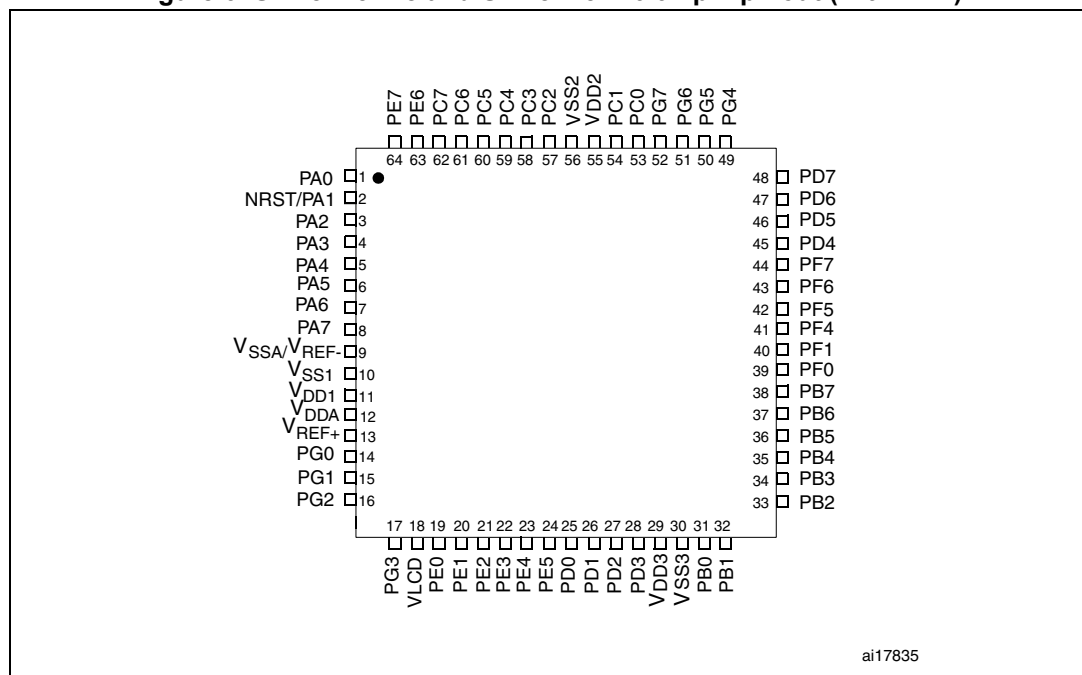
The two comparators can be used together to offer a window function. They can wake up from Halt mode.

Figure 5. STM8L151R8 and STM8L151R6 64-pin pinout (without LCD)



1. Pin 18 is reserved and must be tied to V_{DD} .
2. The above figure shows the package top view.

Figure 6. STM8L152R8 and STM8L152R6 64-pin pinout (with LCD)



1. The above figure shows the package top view.

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 516A	RTC	RTC_CALRH	Calibration register high	0x00 ⁽¹⁾
0x00 516B		RTC_CALRL	Calibration register low	0x00 ⁽¹⁾
0x00 516C		RTC_TCR1	Tamper control register 1	0x00 ⁽¹⁾
0x00 516D		RTC_TCR2	Tamper control register 2	0x00 ⁽¹⁾
0x00 516E to 0x00 518A	Reserved area			
0x00 5190	CSSLSE	CSSLSE_CSR	CSS on LSE control and status register	0x00 ⁽¹⁾
0x00 519A to 0x00 51FF	Reserved area			
0x00 5200	SPI1	SPI1_CR1	SPI1 control register 1	0x00
0x00 5201		SPI1_CR2	SPI1 control register 2	0x00
0x00 5202		SPI1_ICR	SPI1 interrupt control register	0x00
0x00 5203		SPI1_SR	SPI1 status register	0x02
0x00 5204		SPI1_DR	SPI1 data register	0x00
0x00 5205		SPI1_CRCPR	SPI1 CRC polynomial register	0x07
0x00 5206		SPI1_RXCR	SPI1 Rx CRC register	0x00
0x00 5207		SPI1_TXCR	SPI1 Tx CRC register	0x00
0x00 5208 to 0x00 520F	Reserved area (8 byte)			
0x00 5210	I2C1	I2C1_CR1	I2C1 control register 1	0x00
0x00 5211		I2C1_CR2	I2C1 control register 2	0x00
0x00 5212		I2C1_FREQR	I2C1 frequency register	0x00
0x00 5213		I2C1_OARL	I2C1 own address register low	0x00
0x00 5214		I2C1_OARH	I2C1 own address register high	0x00
0x00 5215		I2C1_OARH	I2C1 own address register for dual mode	0x00
0x00 5216		I2C1_DR	I2C1 data register	0x00
0x00 5217		I2C1_SR1	I2C1 status register 1	0x00
0x00 5218		I2C1_SR2	I2C1 status register 2	0x00
0x00 5219		I2C1_SR3	I2C1 status register 3	0x0X
0x00 521A		I2C1_ITR	I2C1 interrupt control register	0x00
0x00 521B		I2C1_CCRL	I2C1 clock control register low	0x00
0x00 521C		I2C1_CCRH	I2C1 clock control register high	0x00
0x00 521D		I2C1_TRISER	I2C1 TRISE register	0x02
0x00 521E		I2C1_PECR	I2C1 packet error checking register	0x00

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 521F to 0x00 522F	Reserved area (17 byte)			
0x00 5230	USART1	USART1_SR	USART1 status register	0xC0
0x00 5231		USART1_DR	USART1 data register	0xFF
0x00 5232		USART1_BRR1	USART1 baud rate register 1	0x00
0x00 5233		USART1_BRR2	USART1 baud rate register 2	0x00
0x00 5234		USART1_CR1	USART1 control register 1	0x00
0x00 5235		USART1_CR2	USART1 control register 2	0x00
0x00 5236		USART1_CR3	USART1 control register 3	0x00
0x00 5237		USART1_CR4	USART1 control register 4	0x00
0x00 5238		USART1_CR5	USART1 control register 5	0x00
0x00 5239		USART1_GTR	USART1 guard time register	0x00
0x00 523A		USART1_PSCR	USART1 prescaler register	0x00
0x00 523B to 0x00 524F	Reserved area (21 byte)			
0x00 5250	TIM2	TIM2_CR1	TIM2 control register 1	0x00
0x00 5251		TIM2_CR2	TIM2 control register 2	0x00
0x00 5252		TIM2_SMCR	TIM2 Slave mode control register	0x00
0x00 5253		TIM2_ETR	TIM2 external trigger register	0x00
0x00 5254		TIM2_DER	TIM2 DMA1 request enable register	0x00
0x00 5255		TIM2_IER	TIM2 interrupt enable register	0x00
0x00 5256		TIM2_SR1	TIM2 status register 1	0x00
0x00 5257		TIM2_SR2	TIM2 status register 2	0x00
0x00 5258		TIM2_EGR	TIM2 event generation register	0x00
0x00 5259		TIM2_CCMR1	TIM2 capture/compare mode register 1	0x00
0x00 525A		TIM2_CCMR2	TIM2 capture/compare mode register 2	0x00
0x00 525B		TIM2_CCER1	TIM2 capture/compare enable register 1	0x00
0x00 525C		TIM2_CNTRH	TIM2 counter high	0x00
0x00 525D		TIM2_CNTRL	TIM2 counter low	0x00
0x00 525E		TIM2_PSCR	TIM2 prescaler register	0x00
0x00 525F		TIM2_ARRH	TIM2 auto-reload register high	0xFF
0x00 5260		TIM2_ARRL	TIM2 auto-reload register low	0xFF
0x00 5261		TIM2_CCR1H	TIM2 capture/compare register 1 high	0x00

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 5386 to 0x00 5387	Reserved area (2 byte)			
0x00 5388	DAC	DAC_CH1RDHRH	DAC channel 1 right aligned data holding register high	0x00
0x00 5389		DAC_CH1RDHRL	DAC channel 1 right aligned data holding register low	0x00
0x00 538A to 0x00 538B	Reserved area (2 byte)			
0x00 538C	DAC	DAC_CH1LDHRH	DAC channel 1 left aligned data holding register high	0x00
0x00 538D	DAC	DAC_CH1LDHRL	DAC channel 1 left aligned data holding register low	0x00
0x00 538E to 0x00 538F	Reserved area (2 byte)			
0x00 5390	DAC	DAC_CH1DHR8	DAC channel 1 8-bit data holding register	0x00
0x00 5391 to 0x00 5393	Reserved area (3 byte)			
0x00 5394	DAC	DAC_CH2RDHRH	DAC channel 2 right aligned data holding register high	0x00
0x00 5395		DAC_CH2RDHRL	DAC channel 2 right aligned data holding register low	0x00
0x00 5396 to 0x00 5397	Reserved area (2 byte)			
0x00 5398	DAC	DAC_CH2LDHRH	DAC channel 2 left aligned data holding register high	0x00
0x00 5399		DAC_CH2LDHRL	DAC channel 2 left aligned data holding register low	0x00
0x00 539A to 0x00 539B	Reserved area (2 byte)			
0x00 539C	DAC	DAC_CH2DHR8	DAC channel 2 8-bit data holding register	0x00
0x00 539D to 0x00 539F	Reserved area (3 byte)			
0x00 53A0	DAC	DAC_DCH1RDHRH	DAC channel 1 right aligned data holding register high	0x00
0x00 53A1		DAC_DCH1RDHRL	DAC channel 1 right aligned data holding register low	0x00
0x00 53A2 to 0x00 53AB	Reserved area (3 byte)			

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 53AC	DAC	DAC_DORH	DAC data output register high	0x00
0x00 53AD		DAC_DORL	DAC data output register low	0x00
0x00 53A2		DAC_DCH2RDHRH	DAC channel 2 right aligned data holding register high	0x00
0x00 53A3		DAC_DCH2RDHRL	DAC channel 2 right aligned data holding register low	0x00
0x00 53A4		DAC_DCH1LDHRH	DAC channel 1 left aligned data holding register high	0x00
0x00 53A5		DAC_DCH1LDHRL	DAC channel 1 left aligned data holding register low	0x00
0x00 53A6		DAC_DCH2LDHRH	DAC channel 2 left aligned data holding register high	0x00
0x00 53A7		DAC_DCH2LDHRL	DAC channel 2 left aligned data holding register low	0x00
0x00 53A8		DAC_DCH1DHR8	DAC channel 1 8-bit mode data holding register	0x00
0x00 53A9		DAC_DCH2DHR8	DAC channel 2 8-bit mode data holding register	0x00
0x00 53AA to 0x00 53AB	Reserved area (2 byte)			
0x00 53AC	DAC	DAC_CH1DORH Reset value	DAC channel 1 data output register high	0x00
0x00 53AD		DAC_CH1DORL Reset value	DAC channel 1 data output register low	0x00
0x00 53AE to 0x00 53AF	Reserved area (2 byte)			
0x00 53B0	DAC	DAC_CH2DORH Reset value	DAC channel 2 data output register high	0x00
0x00 53B1		DAC_CH2DORL Reset value	DAC channel 2 data output register low	0x00
0x00 53B2 to 0x00 53BF	Reserved area			
0x00 53C0	SPI2	SPI2_CR1	SPI2 control register 1	0x00
0x00 53C1		SPI2_CR2	SPI2 control register 2	0x00
0x00 53C2		SPI2_ICR	SPI2 interrupt control register	0x00
0x00 53C3		SPI2_SR	SPI2 status register	0x02
0x00 53C4		SPI2_DR	SPI2 data register	0x00
0x00 53C5		SPI2_CRCPR	SPI2 CRC polynomial register	0x07
0x00 53C6		SPI2_RXCR	SPI2 Rx CRC register	0x00
0x00 53C7		SPI2_TXCR	SPI2 Tx CRC register	0x00

Table 9. General hardware register map (continued)

Address	Block	Register label	Register name	Reset status
0x00 53C8 to 0x00 53DF	Reserved area			
0x00 53E0	USART2	USART2_SR	USART2 status register	0xC0
0x00 53E1		USART2_DR	USART2 data register	0xFF
0x00 53E2		USART2_BRR1	USART2 baud rate register 1	0x00
0x00 53E3		USART2_BRR2	USART2 baud rate register 2	0x00
0x00 53E4		USART2_CR1	USART2 control register 1	0x00
0x00 53E5		USART2_CR2	USART2 control register 2	0x00
0x00 53E6		USART2_CR3	USART2 control register 3	0x00
0x00 53E7		USART2_CR4	USART2 control register 4	0x00
0x00 53E8		USART2_CR5	USART2 control register 5	0x00
0x00 53E9		USART2_GTR	USART2 guard time register	0x00
0x00 53EA		USART2_PSCR	USART2 prescaler register	0x00
0x00 53EB to 0x00 53EF	Reserved area			
0x00 53F0	USART3	USART3_SR	USART3 status register	0xC0
0x00 53F1		USART3_DR	USART3 data register	0xFF
0x00 53F2		USART3_BRR1	USART3 baud rate register 1	0x00
0x00 53F3		USART3_BRR2	USART3 baud rate register 2	0x00
0x00 53F4		USART3_CR1	USART3 control register 1	0x00
0x00 53F5		USART3_CR2	USART3 control register 2	0x00
0x00 53F6		USART3_CR3	USART3 control register 3	0x00
0x00 53F7		USART3_CR4	USART3 control register 4	0x00
0x00 53F8		USART3_CR5	USART3 control register 5	0x00
0x00 53F9		USART3_GTR	USART3 guard time register	0x00
0x00 53FA		USART3_PSCR	USART3 prescaler register	0x00
0x00 53FB to 0x00 53FF	Reserved area			

Table 10. CPU/SWIM/debug module/interrupt controller registers (continued)

Address	Block	Register label	Register name	Reset status
0x00 7F90	DM	DM_BK1RE	DM breakpoint 1 register extended byte	0xFF
0x00 7F91		DM_BK1RH	DM breakpoint 1 register high byte	0xFF
0x00 7F92		DM_BK1RL	DM breakpoint 1 register low byte	0xFF
0x00 7F93		DM_BK2RE	DM breakpoint 2 register extended byte	0xFF
0x00 7F94		DM_BK2RH	DM breakpoint 2 register high byte	0xFF
0x00 7F95		DM_BK2RL	DM breakpoint 2 register low byte	0xFF
0x00 7F96		DM_CR1	DM Debug module control register 1	0x00
0x00 7F97		DM_CR2	DM Debug module control register 2	0x00
0x00 7F98		DM_CSR1	DM Debug module control/status register 1	0x10
0x00 7F99		DM_CSR2	DM Debug module control/status register 2	0x00
0x00 7F9A		DM_ENFCTR	DM enable function register	0xFF
0x00 7F9B to 0x00 7F9F	Reserved area (5 byte)			

1. Accessible by debug module only

6 Interrupt vector mapping

Table 11. Interrupt mapping

IRQ No.	Source block	Description	Wakeup from Halt mode	Wakeup from Active-halt mode	Wakeup from Wait (WFI mode)	Wakeup from Wait (WFE mode) ⁽¹⁾	Vector address
-	RESET	Reset	Yes	Yes	Yes	Yes	0x00 8000
-	TRAP	Software interrupt	-	-	-	-	0x00 8004
0	TLI ⁽²⁾	External Top level Interrupt	-	-	-	-	0x00 8008
1	FLASH	EOP/WR_PG_DIS	-	-	Yes	Yes ⁽³⁾	0x00 800C
2	DMA1 0/1	DMA1 channels 0/1	-	-	Yes	Yes ⁽³⁾	0x00 8010
3	DMA1 2/3	DMA1 channels 2/3	-	-	Yes	Yes ⁽³⁾	0x00 8014
4	RTC/LSE_CSS	RTC alarm interrupt/LSE CSS interrupt	Yes	Yes	Yes	Yes	0x00 8018
5	EXTI E/F/PVD ⁽⁴⁾	PortE/F interrupt/PVD interrupt	Yes	Yes	Yes	Yes ⁽³⁾	0x00 801C
6	EXTIB/G	External interrupt port B/G	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8020
7	EXTID/H	External interrupt port D/H	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8024
8	EXTI0	External interrupt 0	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8028
9	EXTI1	External interrupt 1	Yes	Yes	Yes	Yes ⁽³⁾	0x00 802C
10	EXTI2	External interrupt 2	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8030
11	EXTI3	External interrupt 3	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8034
12	EXTI4	External interrupt 4	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8038
13	EXTI5	External interrupt 5	Yes	Yes	Yes	Yes ⁽³⁾	0x00 803C
14	EXTI6	External interrupt 6	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8040
15	EXTI7	External interrupt 7	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8044
16	LCD	LCD interrupt	-	-	Yes	Yes	0x00 8048
17	CLK/TIM1/DAC	System clock switch/CSS interrupt/TIM1 break/DAC	-	-	Yes	Yes	0x00 804C
18	COMP1/COMP2 ADC1	Comparator 1 and 2 interrupt/ADC1	Yes	Yes	Yes	Yes ⁽³⁾	0x00 8050
19	TIM2/USART2	TIM2 update /overflow/trigger/break/ USART2 transmission complete/transmit data register empty interrupt	-	-	Yes	Yes ⁽³⁾	0x00 8054

Table 13. Option byte description (continued)

Option byte no.	Option description
OPT5	BOR_ON: 0: Brownout reset off 1: Brownout reset on
	BOR_TH[3:1]: Brownout reset thresholds. Refer to Table 19 for details on the thresholds according to the value of BOR_TH bits.
OPTBL	OPTBL[15:0]: This option is checked by the boot ROM code after reset. Depending on the content of addresses 00 480B, 00 480C and 0x8000 (reset vector) the CPU jumps to the bootloader or to the reset vector. Refer to the UM0560 bootloader user manual for more details.

9.3.3 Supply current characteristics

Total current consumption

The MCU is placed under the following conditions:

- All I/O pins in input mode with a static value at V_{DD} or V_{SS} (no load)
- All peripherals are disabled except if explicitly mentioned.

In the following table, data are based on characterization results, unless otherwise specified.

Subject to general operating conditions for V_{DD} and T_A .

Table 20. Total current consumption in Run mode

Symbol	Parameter	Conditions ⁽¹⁾			Typ.	Max.				Unit
						55 °C	85 °C (2)	105 °C (3)	125 °C (4)	
$I_{DD(RUN)}$	Supply current in run mode ⁽⁵⁾	All peripherals OFF, code executed from RAM, V_{DD} from 1.65 V to 3.6 V	HSI RC osc. (16 MHz) ⁽⁶⁾	$f_{CPU} = 125 \text{ kHz}$	0.22	0.28	0.39	0.47	0.51	mA
				$f_{CPU} = 1 \text{ MHz}$	0.32	0.38	0.49	0.57	0.61	
				$f_{CPU} = 4 \text{ MHz}$	0.59	0.65	0.76	0.84	0.88	
				$f_{CPU} = 8 \text{ MHz}$	0.93	0.99	1.1	1.18	1.22	
				$f_{CPU} = 16 \text{ MHz}$	1.62	1.68	1.79 ⁽⁷⁾	1.87 ⁽⁷⁾	1.91 ⁽⁷⁾	
			HSE external clock ($f_{CPU}=f_{HSE}$) ⁽⁸⁾	$f_{CPU} = 125 \text{ kHz}$	0.21	0.25	0.35	0.44	0.49	
				$f_{CPU} = 1 \text{ MHz}$	0.3	0.34	0.44	0.53	0.58	
				$f_{CPU} = 4 \text{ MHz}$	0.57	0.61	0.71	0.8	0.85	
				$f_{CPU} = 8 \text{ MHz}$	0.95	0.99	1.09	1.18	1.23	
				$f_{CPU} = 16 \text{ MHz}$	1.73	1.77	1.87 ⁽⁷⁾	1.96 ⁽⁷⁾	2.01 ⁽⁷⁾	
			LSI RC osc. (typ. 38 kHz)	$f_{CPU} = f_{LSI}$	0.029	0.035	0.039	0.044	0.055	
			LSE external clock (32.768 kHz)	$f_{CPU} = f_{LSE}$	0.028	0.034	0.038	0.042	0.054	

In the following table, data are based on characterization results, unless otherwise specified.

Table 24. Total current consumption and timing in Active-halt mode
at $V_{DD} = 1.65\text{ V}$ to 3.6 V

Symbol	Parameter	Conditions ⁽¹⁾			Typ.	Max.	Unit
$I_{DD(AH)}$	Supply current in Active-halt mode	LSI RC (at 38 kHz)	LCD OFF ⁽²⁾	$T_A = -40\text{ °C to }25\text{ °C}$	0.92	2.25	μA
				$T_A = 55\text{ °C}$	1.32	3.44	
				$T_A = 85\text{ °C}$	1.63	3.87	
				$T_A = 105\text{ °C}$	3	7.94	
				$T_A = 125\text{ °C}$	5.6	13.8	
			LCD ON (static duty/ external V_{LCD}) ⁽³⁾	$T_A = -40\text{ °C to }25\text{ °C}$	1.56	3.6	
				$T_A = 55\text{ °C}$	1.64	3.8	
				$T_A = 85\text{ °C}$	2.12	5.03	
				$T_A = 105\text{ °C}$	3.34	8.2	
				$T_A = 125\text{ °C}$	5.83	14.4	
			LCD ON (1/4 duty/ external V_{LCD}) ⁽⁴⁾	$T_A = -40\text{ °C to }25\text{ °C}$	1.92	4.56	
				$T_A = 55\text{ °C}$	2.1	4.97	
				$T_A = 85\text{ °C}$	2.6	6.14	
				$T_A = 105\text{ °C}$	3.62	8.49	
				$T_A = 125\text{ °C}$	6.1	15.92	
			LCD ON (1/4 duty/ internal V_{LCD}) ⁽⁵⁾	$T_A = -40\text{ °C to }25\text{ °C}$	4.2	9.88	
				$T_A = 55\text{ °C}$	4.39	10.32	
				$T_A = 85\text{ °C}$	4.84	11.5	
				$T_A = 105\text{ °C}$	5.98	15	
				$T_A = 125\text{ °C}$	7.21	18.07	

5. Data based on a differential I_{DD} measurement between DAC in reset configuration and continuous DAC conversion of $V_{DD}/2$. Floating DAC output.
6. Data based on a differential I_{DD} measurement between COMP1 or COMP2 in reset configuration and COMP1 or COMP2 enabled with static inputs. Supply current of internal reference voltage excluded.
7. Including supply current of internal reference voltage.

Table 28. Current consumption under external reset

Symbol	Parameter	Conditions		Typ.	Unit
I _{DD(RST)}	Supply current under external reset ⁽¹⁾	PB1/PB3/PA5 pins are externally tied to V _{DD}	V _{DD} = 1.8 V	48	μA
			V _{DD} = 3 V	80	
			V _{DD} = 3.6 V	95	

1. All pins except PA0, PB0 and PB4 are floating under reset. PA0, PB0 and PB4 are configured with pull-up under reset. PB1, PB3 and PA5 must be tied externally under reset to avoid the consumption due to their schmitt trigger.

9.3.4 Clock and timing characteristics

HSE external clock (HSEBYP = 1 in CLK_ECKCR)

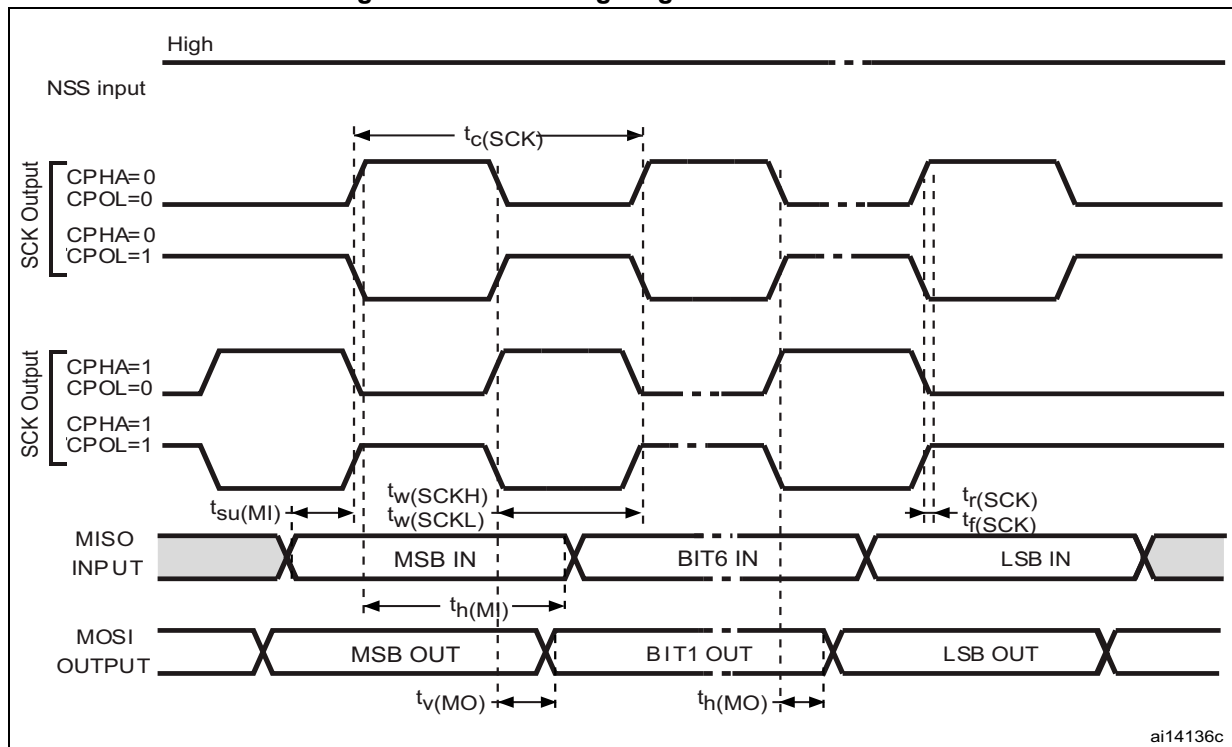
Subject to general operating conditions for V_{DD} and T_A .

Table 29. HSE external clock characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$f_{HSE_ext}^{(1)}$	External clock source frequency		1		16	MHz
V_{HSEH}	OSC_IN input pin high level voltage		$0.7 \times V_{DD}$		V_{DD}	V
V_{HSEL}	OSC_IN input pin low level voltage		V_{SS}		$0.3 \times V_{DD}$	
$C_{in(HSE)}^{(1)}$	OSC_IN input capacitance			2.6		pF
I_{LEAK_HSE}	OSC_IN input leakage current	$V_{SS} < V_{IN} < V_{DD}$			± 1	μA

1. Guaranteed by design.

Figure 41. SPI1 timing diagram - master mode



1. Measurement points are done at CMOS levels: $0.3V_{DD}$ and $0.7V_{DD}$.

Table 49. Comparator 2 characteristics

Symbol	Parameter	Conditions	Min	Typ	Max ⁽¹⁾	Unit
V_{DDA}	Analog supply voltage	-	1.65		3.6	V
V_{IN}	Comparator 2 input voltage range	-	0		V_{DDA}	V
t_{START}	Comparator startup time	Fast mode	-	15	20	μs
		Slow mode	-	20	25	
$t_{d\ slow}$	Propagation delay ⁽²⁾ in slow mode	$1.65\ V \leq V_{DDA} \leq 2.7\ V$	-	1.8	3.5	
		$2.7\ V \leq V_{DDA} \leq 3.6\ V$	-	2.5	6	
$t_{d\ fast}$	Propagation delay ⁽²⁾ in fast mode	$1.65\ V \leq V_{DDA} \leq 2.7\ V$	-	0.8	2	
		$2.7\ V \leq V_{DDA} \leq 3.6\ V$	-	1.2	4	
V_{offset}	Comparator offset error	-	-	± 4	± 20	mV
$d_{Threshold}/dt$	Threshold voltage temperature coefficient	$V_{DDA} = 3.3V$ $T_A = 0\ to\ 50\ ^\circ C$ $V_- = V_{REF+},\ 3/4\ V_{REF+},\ 1/2\ V_{REF+},\ 1/4\ V_{REF+}$	-	15	30	ppm/ $^\circ C$
I_{COMP2}	Current consumption ⁽³⁾	Fast mode	-	3.5	5	μA
		Slow mode	-	0.5	2	

1. Based on characterization.

2. The delay is characterized for 100 mV input step with 10 mV overdrive on the inverting input, the non-inverting input set to the reference.

3. Comparator consumption only. Internal reference voltage (necessary for comparator operation) is not included.

9.3.14 12-bit ADC1 characteristics

In the following table, data are guaranteed by design.

Table 53. ADC1 characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V _{DDA}	Analog supply voltage	-	1.8		3.6	V
V _{REF+}	Reference supply voltage	2.4 V ≤V _{DDA} ≤ 3.6 V	2.4		V _{DDA}	
		1.8 V≤V _{DDA} ≤ 2.4 V	V _{DDA}			
V _{REF-}	Lower reference voltage	-	V _{SSA}			
I _{VDDA}	Current on the V _{DDA} input pin	-	-	1000	1450	μA
I _{VREF+}	Current on the V _{REF+} input pin	-	-	400	700 (peak) ⁽¹⁾	
		-	-		450 (average) ⁽¹⁾	
V _{AIN}	Conversion voltage range	-	0 ⁽²⁾	-	V _{REF+}	
T _A	Temperature range	-	-40	-	125	°C
R _{AIN}	External resistance on V _{AIN}	on PF0/1/2/3 fast channels	-	-	50 ⁽³⁾	kΩ
		on all other channels	-	-		
C _{ADC}	Internal sample and hold capacitor	on PF0/1/2/3 fast channels	-	16	-	pF
		on all other channels	-		-	
f _{ADC}	ADC sampling clock frequency	2.4 V≤V _{DDA} ≤3.6 V without zooming	0.320	-	16	MHz
		1.8 V≤V _{DDA} ≤2.4 V with zooming	0.320	-	8	
f _{CONV}	12-bit conversion rate	V _{AIN} on PF0/1/2/3 fast channels	-	-	1 ⁽³⁾⁽⁴⁾	
		V _{AIN} on all other channels	-	-	760 ⁽³⁾⁽⁴⁾	kHz
f _{TRIG}	External trigger frequency	-	-	-	t _{conv}	1/f _{ADC}
t _{LAT}	External trigger latency	-	-	-	3.5	1/f _{SYSCLK}

11 Ordering information scheme

Table 69. Ordering information scheme

Example:	STM8	L	152	C	8	T	6	D	xx
Device family									
STM8 microcontroller									
Product type									
L = Low-power									
Device subfamily									
151: Devices without LCD									
152: Devices with LCD									
Pin count									
K = 32 balls									
C = 48 pins									
R = 64 pins									
M = 80 pins									
Program memory size									
8 = 64 Kbyte of Flash memory									
6 = 32 Kbyte of Flash memory									
Package									
T = LQFP									
U = UFQFPN									
Y = WLCSP32									
Temperature range									
3 = Industrial temperature range, – 40 to 125 °C									
7 = Industrial temperature range, – 40 to 105 °C									
6 = Industrial temperature range, – 40 to 85 °C									
Option									
Blank = V _{DD} range from 1.8 to 3.6 V and BOR enabled									
D = V _{DD} range from 1.65 to 3.6 V and BOR disabled									
Packing									
TR = tape and reel									

For a list of available options (e.g. memory size, package) and order-able part numbers or for further information on any aspect of this device, please go to www.st.com or contact the ST Sales Office nearest to you.